



MICROCHIP

dsPIC33FJ256MCX06A/X08A/X10A

dsPIC33FJ256MCX06A/X08A/X10A Family Silicon Errata and Data Sheet Clarification

The dsPIC33FJ256MCX06A/X08A/X10A family devices that you have received conform functionally to the current Device Data Sheet (DS70594B), except for the anomalies described in this document.

The silicon issues discussed in the following pages are for silicon revisions with the Device and Revision IDs listed in [Table 1](#). The silicon issues are summarized in [Table 2](#).

The errata described in this document will be addressed in future revisions of the dsPIC33FJ256MCX06A/X08A/X10A silicon.

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated in the last column of [Table 2](#) apply to the current silicon revision (**A3**).

Data Sheet clarifications and corrections start on [page 6](#), following the discussion of silicon issues.

The silicon revision level can be identified using the current version of MPLAB® IDE and Microchip's programmers, debuggers and emulation tools, which are available at the Microchip corporate web site (www.microchip.com).

For example, to identify the silicon revision level using MPLAB IDE in conjunction with MPLAB ICD 2 or PICkit™ 3:

1. Using the appropriate interface, connect the device to the MPLAB ICD 2 programmer/debugger or PICkit 3.
2. From the main menu in MPLAB IDE, select *Configure>Select Device*, and then select the target part number in the dialog box.
3. Select the MPLAB hardware tool (*Debugger>Select Tool*).
4. Perform a "Connect" operation to the device (*Debugger>Connect*). Depending on the development tool used, the part number *and* Device Revision ID value appear in the **Output** window.

Note: If you are unable to extract the silicon revision level, please contact your local Microchip sales office for assistance.

The Device and Revision ID values for the various dsPIC33FJ256MCX06A/X08A/X10A silicon revisions are shown in [Table 1](#).

TABLE 1: SILICON DEVREV VALUES

Part Number	Device ID ⁽¹⁾	Revision ID for Silicon Revision ⁽²⁾	
		A2	A3
dsPIC33FJ256MC510A	0x07B7	0x3002	0x3003
dsPIC33FJ256MC710A	0x07BF		

- Note 1:** The Device and Revision IDs (DEVID and DEVREV) are located at the last two implemented addresses in program memory.
- 2:** Refer to the "dsPIC33F/PIC24H Flash Programming Specification" (DS70152) for detailed information on Device and Revision IDs for your specific device.

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TABLE 2: SILICON ISSUE SUMMARY

Module	Feature	Item Number	Issue Summary	Affected Revisions ⁽¹⁾	
				A2	A3
ECAN	WAKIF bit	1.	The WAKIF bit in the CxINTF register cannot be cleared by software instruction after the device is interrupted from Sleep due to activity on the CAN bus.	X	X
ECAN	DMA	2.	False DMA Error Traps may be generated in applications that perform both transmissions and receptions using ECAN with DMA.	X	
QEI	Timer Gated Accumulation	3.	When Timer Gated Accumulation is enabled, the QEI does not generate an interrupt on every falling edge.	X	X
QEI	Timer Gated Accumulation	4.	When Timer Gated Accumulation is enabled, and an external signal is applied, the POSCNT increments and generates an interrupt after a match with MAXCNT.	X	X
UART	Break Characters	5.	The UART module will not generate consecutive break characters.	X	X
ADC	DONE bit	6.	The ADC Conversion Status bit (DONE) does not work when External Interrupt is selected as the ADC trigger source.	X	X
SPI	TBF bit	7.	Writing to the SPIBUF register as soon as the TBF bit is cleared will cause the SPI module to ignore the written data.	X	X
DMA Controller	CPU Write Collision Detection	8.	DMA CPU write collisions will not be detected.		X
ADC	Current Consumption in Sleep Mode	9.	If the ADC module is in an enabled state when the device enters Sleep Mode, the power-down current (IPD) of the device may exceed the device data sheet specifications.	X	X
All	150°C Operation	10.	Affected revisions of silicon only support 140°C operation instead of 150°C for extended operating temperature.	X	X

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

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Silicon Errata Issues

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated by the shaded column in the following tables apply to the current silicon revision (**A3**).

1. Module: ECAN

The WAKIF bit in the CxINTF register cannot be cleared by software instruction after the device is interrupted from Sleep due to activity on the CAN bus.

When the device wakes up from Sleep due to CAN bus activity, the ECAN module is placed in operational mode. The ECAN Event interrupt occurs due to the WAKIF flag. Trying to clear the flag in the Interrupt Service Routine (ISR) may not clear the flag. The WAKIF bit being set will not cause repetitive Interrupt Service Routine execution.

Work around

Although the WAKIF bit does not clear, the device Sleep and ECAN Wake functions continue to work as expected. If the ECAN event is enabled, the CPU will enter the Interrupt Service Routine due to the WAKIF flag getting set. The application can maintain a secondary flag, which tracks the device Sleep and Wake events.

Affected Silicon Revisions

A2	A3						
X	X						

2. Module: ECAN

In user applications that perform both transmissions and receptions using ECAN with DMA, intermittent DMA Write Collisions might get generated, resulting in the generation of DMA Error Traps. The ECAN messages would be transmitted and received correctly even when these DMA Error Traps occur.

Work around

Within the DMA Error Trap service routine in the application software, read the DMACS0 register and inspect the two XWCOLn (n = 0, 1, ...,7) bits corresponding to the DMA channels being used for ECAN transmission and reception.

For example, if DMA Channel 1 is used for ECAN Reception and DMA Channel 2 is used for ECAN Transmission, inspect the XWCOL1 and XWCOL2 bits. If either of these bits is found to be set, clear the DMACERR bit in the INTCON1 register and return from the DMA Error Trap service routine.

Affected Silicon Revisions

A2	A3						
X							

3. Module: QEI

When the TQCS and TQGATE bits in the QEIXCON register are set, a QEI interrupt should be generated after an input pulse on the QEA input. This interrupt is not generated in the affected silicon.

Work around

None.

Affected Silicon Revisions

A2	A3						
X	X						

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4. Module: QEI

When the TQCS and TQGATE bits in the QEIxCON register are set, the POSCNT counter should not increment but erroneously does, and if allowed to increment to match MAXCNT, a QEI interrupt will be generated.

Work around

To prevent the erroneous increment of POSCNT while running the QEI in Timer Gated Accumulation mode, initialize MAXCNT = 0.

Affected Silicon Revisions

A2	A3						
X	X						

5. Module: UART

The UART module will not generate consecutive break characters. Trying to perform a back-to-back Break character transmission will cause the UART module to transmit the dummy character used to generate the first Break character instead of transmitting the second Break character. Break characters are generated correctly if they are followed by non-Break character transmission.

Work around

None.

Affected Silicon Revisions

A2	A3						
X	X						

6. Module: ADC

The ADC Conversion Status (DONE) bit (ADxCON1<0>) does not indicate completion of conversion when External Interrupt is selected as the ADC trigger source (ADxCON1<SSRC> = 1).

Work around

Use an ADC interrupt or poll ADxIF bit in the IFSx registers to determine the completion of conversion.

Affected Silicon Revisions

A2	A3						
X	X						

7. Module: SPI

Writing to the SPIxBUF register as soon as the TBF bit is cleared will cause the SPI module to ignore the written data. *Applications that use SPI with DMA are not affected by this erratum.*

Work around

After the TBF bit is cleared, wait for a minimum duration of one SPI clock before writing to the SPIxBUF register.

Alternately, do one of the following:

- Poll the RBF bit and wait for it to get set before writing to the SPIxBUF register
- Poll the SPI Interrupt flag and wait for it to get set before writing to the SPIxBUF register
- Use an SPI Interrupt Service Routine
- Use DMA

Affected Silicon Revisions

A2	A3						
X	X						

8. Module: DMA Controller

DMA CPU write collisions will not be detected, and the corresponding XWCOLn bit (n = 0, 1, ..., 7) will not be set. As a result, a CPU write collision event will not generate a DMA Error Trap.

Work around

None. Before writing to any memory location in DMA RAM, ensure that none of the enabled DMA channels is using the same memory location for data transfers from a peripheral.

A2	A3						
	X						

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9. Module: ADC

If the ADC module is in an enabled state when the device enters Sleep mode as a result of executing a `PWRSVAV #0` instruction, the device power-down current (IPD) may exceed the specifications listed in the device data sheet. This may happen even if the ADC module is disabled by clearing the ADON bit prior to entering Sleep mode.

Work around

In order to remain within the IPD specifications listed in the device data sheet, the user software must completely disable the ADC module by setting the ADC Module Disable bit in the corresponding Peripheral Module Disable register (PMDx), prior to executing a `PWRSVAV #0` instruction.

Affected Silicon Revisions

A2	A3						
X	X						

10. Module: All

The affected silicon revisions listed below are not warranted for operation at 150°C.

Work around

Only use the affected revisions of silicon for Hi-Temp operating range from -40°C to +140°C.

Affected Silicon Revisions

A2	A3						
X	X						

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Data Sheet Clarifications

The following typographic corrections and clarifications are to be noted for the latest version of the device data sheet (DS70594B):

Note: Corrections are shown in **bold**. Where possible, the original bold text formatting has been removed for clarity.

1. Module: DC Characteristics: I/O Pin Input Specifications

The maximum value for parameter DI19 (V_{IL} specifications for SDAx and SCLx pins) was stated incorrectly in Table 26-9 of the current device data sheet. Also, parameters DI28 and DI29 (V_{IH} specifications for SDAx and SCLx pins) were not stated. The correct values are shown in bold type in [Table 3](#).

TABLE 3: DC CHARACTERISTICS: I/O PIN INPUT SPECIFICATIONS

DC CHARACTERISTICS			Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$ for Industrial $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ for Extended				
Param No.	Symbol	Characteristic	Min	Typ	Max	Units	Conditions
DI18	V_{IL}	Input Low Voltage SDAx, SCLx	V_{SS}	—	$0.3 V_{DD}$	V	SMBus disabled
DI19		SDAx, SCLx	V_{SS}	—	0.8	V	SMBus enabled
DI28	V_{IH}	Input High Voltage SDAx, SCLx	$0.7 V_{DD}$	—	5.5	V	SMBus disabled
DI29		SDAx, SCLx	2.1	—	5.5	V	SMBus enabled

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APPENDIX A: REVISION HISTORY

Rev A Document (9/2009)

Initial release of this document; issued for revision A2 silicon.

Includes silicon issues 1-2 ([ECAN](#)), 3-4 ([QEI](#)), 5 ([UART](#)), 6 ([ADC](#)) and 7 ([SPI](#)).

Rev B Document (12/2009)

Added silicon issue 8 ([DMA Controller](#)).

Rev C Document (6/2010)

Added silicon issue 9 ([ADC](#)) and data sheet clarification 1 ([DC Characteristics: I/O Pin Input Specifications](#)).

Rev D Document (9/2010)

Added silicon issue 10 ([All](#)).

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NOTES:

Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as “unbreakable.”

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ISBN: 978-1-60932-494-0

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08/04/10